	Application No.	Applicant(s)	
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Notice of Allowability	10/526,059	ELLISON ET AL.	
	Examiner	Art Unit	
	NICOLE T. GUGLIOTTA	1794	
The MAILING DATE of this communication appeal all claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R	(OR REMAINS) CLOSED in the or other appropriate communic IGHTS. This application is sub-	is application. If not included action will be mailed in due course. Th	
1. This communication is responsive to 8/25/2008.			
2. ☑ The allowed claim(s) is/are <u>1 - 6 & 32 - 37</u> .			
 3. Acknowledgment is made of a claim for foreign priority ur a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 	e been received.		
3. Copies of the certified copies of the priority do	cuments have been received in	this national stage application from the	he
International Bureau (PCT Rule 17.2(a)).			
* Certified copies not received:			
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		reply complying with the requirements	S
4. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give			=
5. CORRECTED DRAWINGS (as "replacement sheets") mus	st be submitted.		
(a) including changes required by the Notice of Draftspers	son's Patent Drawing Review (PTO-948) attached	
1) 🔲 hereto or 2) 🔲 to Paper No./Mail Date	•		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in	the Office action of	
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t			
6. DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT			
Attachment(s)	E Notice of Inform	mal Datant Application	
1. Notice of References Cited (PTO-892)		mal Patent Application	
 Notice of Draftperson's Patent Drawing Review (PTO-948) Information Disclosure Statements (PTO/SB/08), 	6. ⊠ Interview Sum Paper No./Ma 7. ⊠ Examiner's An	il Date	
Paper No./Mail Date			
 Examiner's Comment Regarding Requirement for Deposit of Biological Material 		atement of Reasons for Allowance	
	9. Other		
	/Carol Chaney/ Supervisory Pater	t Examiner, Art Unit 1794	

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DETAILED ACTION

EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Eric Franklin on September 12, 2008.

The application has been amended as follows: cancel claims 7 - 31.

Allowable Subject Matter

- 2. Claims 1 6 & 32 37 allowed.
- 3. The following is an examiner's statement of reasons for allowance:
- 4. The nearest prior art is Carter, Jr. et al. (U.S. Patent No. 6,218,680) and Kordina et al. (Appl. Phys. Lett. **66** (2), January 1995).
- 5. The instant application claims "a uniform single crystal silicon carbide wafer with either an n-type or a p-type conductivity, wherein the crystal has a net carrier concentration less than 10¹⁵ cm⁻³ and a carrier lifetime of at least 50 ns at room temperature, wherein the single crystal is a wafer". These limitations are not obvious over the prior art. Carter, Jr. et al. disclose carrier concentrations within applications range. However, Carter, Jr. et al. are silent in regard to the carrier lifetime. Kordina et

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al. disclose a silicon carbide epitaxial layer substrate applied to a silicon carbide single crystal with a carrier lifetime of $0.45~\mu s$ (450~n s). However, Kordina et al. do not disclose the carrier lifetime for a uniform single crystal silicon carbide wafer. Therefore, based on the nearest prior art, one would not expect a uniform single crystal silicon carbide wafer with a carrier lifetime of greater than 50~n s.

6. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to NICOLE T. GUGLIOTTA whose telephone number is (571)270-1552. The examiner can normally be reached on M - Th 8:30 - 6 p.m., & every other Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carol Chaney can be reached on 571-272-1284. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

NICOLE T. GUGLIOTTA Examiner Art Unit 1794

/Carol Chaney/

Supervisory Patent Examiner, Art Unit 1794